

**Notice of References Cited**

Application/Control No.

10/575,764

Applicant(s)/Patent Under  
Reexamination  
IWAI ET AL.

Examiner

ALAN B. WAITS

Art Unit

3656

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0200831 A1	10-2003	Matsumoto et al.	74/490.06
*	B	US-2005/0034552 A1	02-2005	Back et al.	074/490.02
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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